Search Notes



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Examiner

Christian A. Hannon

Applicant(s)/Patent under Reexamination

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Art Unit

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SEARCHED				
Class	Subclass	Date	Examiner	
455	575.5	8/30/2007	СН	
455	280	8/30/2007	СН	
455	285	8/30/2007	СН	
455	283	8/30/2007	СН	
439	59	8/30/2007	СН	
439	63	8/30/2007	СН	
439	76.1	8/30/2007	СН	
439	55	8/30/2007	СН	
439	44	8/30/2007	СН	
439	45	8/30/2007	СН	
439	49	8/30/2007	СН	

INTERFERENCE SEARCHED				
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Consulted E. Urban, see printout.	8/30/2007	СН
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